## REFERENCE DESIGNATION

## **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
100	4,311,876	Jan. 19, 1982	Endo et al.		
1006	6,370,377	Apr. 9, 2002	Take et al.	REC	EIVE
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## FOREIGN PATENT DOCUMENTS

					TRANSLATION			
	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO (Abstract)
103	JP-A-S61-216537	9/26/86	JAPAN	/				X
Cash	JP-A-H05-136724	6/1/93	JAPAN					X
616	JP-A-H11-146464	5/28/99	JAPAN		1/			X
(Ob)	JP-A-S55-143854	11/10/80	JAPAN			/,		Х
04	JP-A-H04-157820	5/29/92	JAPAN	-/		/\		Х
1245	JP-A-H04-207532	7/29/92	JAPAN			'/		X
100	EP 0 843 380 A2	11/13/97	Europe	/				

<sup>\*</sup> Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office) English language web site at http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA11NDEX.

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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